Search Notes				
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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/541,962	NISHIMOTO ET AL.	
Examiner	Art Unit	
Dimple N. Bodawala	1722	

Dimple N. Bodawala

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Class	Subclass	Date	Examiner
425	352+	4/9/2007	DB
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SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
Inventor's name search on eDAN	4/20/2007	DB
BRS Text search on EAST	4/6/2007	DB
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